

Notice of References Cited

Application/Control No.

10/783,086

Applicant(s)/Patent Under
Reexamination
HAN ET AL.

Examiner

Edward T. La Barr

Art Unit

2609

Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,371,845 A	12-1994	Newell et al.	715/808
*	B	US-5,619,630 A	04-1997	Minami et al.	345/619
*	C	US-6,016,147 A	01-2000	Gantt, Brian D.	345/420
*	D	US-6,037,945 A	03-2000	Loveland, James B.	345/420
*	E	US-6,063,128 A	05-2000	Bentley et al.	703/6
*	F	US-6,219,049 B1	04-2001	Zuffante et al.	715/764
*	G	US-2002/0107673 A1	08-2002	Haller et al.	703/1
*	H	US-6,434,441 B1	08-2002	Beauchamp et al.	700/98
*	I	US-2005/0162419 A1	07-2005	Kim et al.	345/419
*	J	US-7,079,990 B2	07-2006	Haller et al.	703/2
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.